Generalization

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Reading

- Chapters 7.1, 7.2
	- Hastie, Trevor, et al. The elements of statistical learning: data mining, inference, and prediction. Vol. 2. New York: springer, 2009.
	- Available online:<https://hastie.su.domains/Papers/ESLII.pdf>
- Zhang, Chiyuan, Samy Bengio, Moritz Hardt, Benjamin Recht, and Oriol Vinyals. "Understanding deep learning (still) requires rethinking generalization." *Communications of the ACM* 64, no. 3 (2021): 107-115.

Overview

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- Generalization is a central concept in all areas of ML
- Just because your model works on your training data doesn't mean it will work on your test data
	- –One can go further: even if your model works on your test data, it doesn't mean it will work on new test data
		- But that's "better" evidence than working on training data
- Generalization is particularly important in deep learning – Neural networks can overfit any dataset we currently have
	- Users need to always be careful about generalization
- We'll discuss how to estimate generalization error and what makes a model more likely to overfit

Training vs Test Data

- Almost any supervised ML task involves the collection of data
- Typically, once the data is collected, we split it into 3 sets:
	- Training set
	- Validation set
	- Test set
- Historically, datasets weren't large enough for such a split, so researchers had to develop other techniques
	- E.g., cross validation
- But the end goal is the same
	- If we develop a model based on the data we have, how well does this model perform on new data?

- Let D_{tr} , D_{v} , D_{te} be the training, validation and test sets, respectively
- Each of those sets is drawn IID from the same distribution D
- The error of a model f on a dataset D is defined as:

$$
Err_D(f) = \frac{1}{|D|} \sum_{(x,y)\in D} I(f(x) \neq y)
$$

 $-$ Where \bm{I} is the indicator function

• $I(f(x) \neq y) = 1$ when $f(x) \neq y$ and 0, otherwise

- The generalization error of a model f is defined as: $GE(f) = \mathbb{P}[f(X) \neq Y]$
	- where (X, Y) ~ \mathcal{D}

– i.e., it is the probability of making an error on unseen data

• An unbiased estimate of the generalization error is the classifier's performance on the test set:

$$
\widehat{GE}(f) = Err_{D_{te}}(f)
$$

• An estimator is said to be unbiased if its expected value is equal to the quantity it is trying to estimate

$$
-\mathsf{E.g.,}\,\mathbb{E}\big[Err_{D_{te}}(f)\big] = GE(f)
$$

- Why?
- $-$ Consider any random test set D
- All $(x_i, y_i) \in D$ are drawn IID from some distribution $\mathcal D$
	- Each corresponds to a random variable (X_i, Y_i)

• An unbiased estimate of the generalization error is the classifier's performance on the test set:

$$
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• An estimator is said to be unbiased if its expected value is equal to the quantity it is trying to estimate

$$
- \mathsf{E.g.,}\ \mathbb{E}\big[Err_{D_{te}}(f)\big] = GE(f);
$$
\n
$$
\mathbb{E}\big[Err_D(f)\big] = \frac{1}{|D|} \sum_{i} \mathbb{E}\big[I(f(X_i) \neq Y_i)\big]
$$
\n
$$
= \frac{1}{|D|} \sum_{i} \mathbb{P}\big[f(X_i) \neq Y_i\big] = \frac{1}{|D|} \sum_{i} \mathbb{P}\big[f(X_1) \neq Y\big]
$$
\n
$$
= \frac{|D|}{|D|} \mathbb{P}\big[f(X_1) \neq Y\big]
$$

- Being unbiased is a nice property but it's not enough
	- The test error on a single point is also an unbiased estimate
	- But if we do well on a larger test set, that is better than doing well on a smaller test set!
	- We can use the Law of Large Numbers and Hoeffding's inequality to further analyze our model's performance

- Let $X_1, ..., X_n$ be *n* IID random variables
- Let $S_n = X_1 + \cdots + X_n$
- (Weak) Law of Large Numbers:

$$
\mathbb{P}\left[\left|\frac{S_n}{n} - \mathbb{E}[X_1]\right| < \epsilon\right] \to 1 \text{ as } n \to \infty
$$

 $-$ for any positive ϵ

• As we collect more data, the sample mean S_n/n converges to the expected mean $\mathbb{E}[X_1]$

— Since the X_i are IID, $\mathbb{E}[X_1]=\mathbb{E}[X_i]$ for any i

The Benefit of the Law of Large Numbers

$$
\mathbb{P}\left[\left|\frac{S_n}{n} - \mathbb{E}[X_1]\right| < \epsilon\right] \to 1 \text{ as } n \to \infty
$$

• Think of $\frac{S_n}{n}$ \overline{n} as your model's test error

$$
Err_D(f) = \frac{1}{|D|} \sum_{(x,y)\in D} I(f(x) \neq y)
$$

$$
-\text{Here, } S_n := \sum_{(x,y)\in D} I(f(x) \neq y) \text{ and } n := |D|
$$

- So the test error converges to the true expected error as the test set gets large
- Practically speaking, the larger the dataset the better
	- E.g., if your model achieves good accuracy on a large test set, then it will likely work well on new data also

Probability Aside: Hoeffding's Inequality

- Suppose your model has good accuracy on a test set
	- Is it possible that you just got lucky and your model isn't that great after all?
- Let $X_1, ..., X_n$ be *n* independent random variables $-$ Each bounded by $a_i \leq X_i \leq b_i$
- Let $S_n = X_1 + \cdots + X_n$
- Hoeffding's Theorem:

$$
\mathbb{P}[S_n - \mathbb{E}[S_n] \ge t] \le \exp\left\{-\frac{2t^2}{\sum_{i=1}^n (b_i - a_i)^2}\right\}
$$

• Two-tailed version:

$$
\mathbb{P}[|S_n - \mathbb{E}[S_n]| \ge t] \le 2 \exp\left\{-\frac{2t^2}{\sum_{i=1}^n (b_i - a_i)^2}\right\}
$$

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Probability Aside: Hoeffding's Inequality, cont'd

• Hoeffding's Theorem:

$$
\mathbb{P}[S_n - \mathbb{E}[S_n] \ge t] \le \exp\left\{-\frac{2t^2}{\sum_{i=1}^n (b_i - a_i)^2}\right\}
$$

- A type of concentration bound
- Given a sample S_n , we can bound its deviation from the true mean
- The larger t is, the higher the probability the mean is within t of the sample
- The smaller the bounds $(b_i a_i)$, the tighter the bound on S_n

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Probability Aside: Hoeffding's Inequality, cont'd

- Suppose each X_i is Bernoulli, i.e., $X_i \in \{0,1\}$, i.e., $b_i a_i = 1$ $-$ E.g., X_i denotes correct or wrong classification on example i
- The bound simplifies to:

$$
\mathbb{P}[S_n - \mathbb{E}[S_n] \ge t] \le \exp\left\{-\frac{2t^2}{n}\right\}
$$

- Furthermore, suppose we are interested in bounding the mean
	- E.g., your model's accuracy

$$
\mathbb{P}\left[\frac{1}{n}(S_n - \mathbb{E}[S_n]) \ge t\right] =
$$

=
$$
\mathbb{P}[S_n - \mathbb{E}[S_n] \ge nt] \le \exp\{-2t^2n\}
$$

• For fixed t , the sample mean is less likely to be farther from the expected mean as we collect more data

- Suppose we have trained a model f
- As far as the test set is concerned, f is now just a function
- Suppose the test set is (x_1, y_1) , ..., (x_n, y_n)
	- In other words, we have realizations of IID variables $(X_1, Y_1), \ldots, (X_n, Y_n)$
- Define the variable $Z_i = 1$ if $f(X_i) = Y_i$ and 0, otherwise
	- $-$ Then the Z_i are IID Bernoulli variables
	- The expected value $\mathbb{E}[Z_i]$ is the true accuracy of f
	- The sample mean $\frac{1}{n}$ $\frac{1}{n}\sum_i z_i$ is the accuracy of f on the test set
- How can we bound $\mathbb{E}[Z_i]$ in terms of $\frac{1}{n}$ $\frac{1}{n}\sum_{i}Z_{i}$?

 $-$ We can directly apply Hoeffding's inequality on the test set

- Suppose our model achieves a test accuracy of 80% over 1000 datapoints
	- What's the probability the true accuracy is less than 70%?
	- Note that $\mathbb{P}\left[\frac{1}{n}\right]$ $\frac{1}{n}$ (E[S_n] – S_n) $\leq -t$] = P 1 $\frac{1}{n}(S_n - \mathbb{E}[S_n]) \geq t$
	- Then, using Hoeffding's inequality:

$$
\mathbb{P}\left[\frac{1}{n}(S_n - \mathbb{E}[S_n]) \ge t\right] =
$$

$$
\mathbb{P}\left[\frac{1}{n}(S_n - \mathbb{E}[S_n]) \ge 0.1\right] \le
$$

$$
\exp\{-2 * 0.1^2 * 1000\} \approx 2 * 10^{-9}
$$

• Even 1000 points give us strong probabilistic guarantees

- Can we apply Hoeffding's inequality to the training set?
	- $-$ Suppose training set is (x_1, y_1) , ..., (x_N, y_N)
	- $-\text{Let } z_i$ be the same as before
	- $-$ The z_i are no longer independent!
		- f is function of all (x_i, y_i) , so the $f(x_i)$ are not independent
- Intuitively, it makes sense that we can't evaluate our model on the training data
	- As with any training task, you eventually remember the task too well (you overfit!)
- There are some cases where we can bound the test set performance in terms of training set performance
	- VC dimension!

What about the validation set?

- In theory, the model f is only trained on the training set
- In practice, we choose different hyper-parameters of f and iterate the training process
	- E.g., number of neighbors in KNN
	- After each iteration, we evaluate the model's accuracy on the validation set only (not the test set!)
	- Why?
	- We can overfit the hyper-parameter values also
- Once we train a good model, we evaluate on the test set
	- If there is a big difference between the test and validation sets, then overfitting is likely to blame

Cross Validation

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- When the test set is not large (a few dozen examples), Hoeffding's inequality provides loose bounds
- Cross validation very useful in this case
	- Split the data randomly into 90% training and 10% testing
	- Train on the training data and record the test accuracy
	- Repeat multiple (e.g., 10) times
	- Take the average test error over all runs
	- A better estimate of generalization error than a single split
- Most modern datasets are big enough such that this is no longer an issue
	- Cross validation is still useful but is not commonly used since it's quite computationally expensive

- We've already seen examples of models that perfectly overfit the training data without having any generalization capacity
	- E.g., a table with rules
- Turns out this is a general phenomenon that has to do with a model's complexity
	- The more complex a model is, the easier it is to achieve zero training error
	- However, it is also easier to overfit

Model Complexity vs Generalization

• Typically, there exists a point beyond which increasing the model complexity does not bring any generalization benefits

- Book authors trained a LASSO algorithm on simulated data
- LASSO is a more sophisticated regression technique
	- See book if you are interested

Model Complexity vs Generalization

• Typically, there exists a point beyond which increasing the model complexity does not bring any generalization benefits

- As the model complexity is increased:
	- Train error (bias) decreases, but eventually test error starts increasing (overfitting!)
	- Test error variance increases; models are sensitive to training noise

Understanding deep learning (still) requires rethinking generalization

Overview

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- This paper is actually an updated version of a 2017 paper with the same name (without the 'still')
- The authors show that generalization is not a well understood notion
	- In classical learning theory, good performance on the training set should lead to similar performance on the test set (when overfitting precautions have been made)

– This paper shows that this need not be the case

• The notion of a "distribution" is really not well defined (at least in the case of images)

- The classical approach is to quantify the classifier's expressive power (also known as capacity)
- Intuitively, argument works as follows:
	- Suppose you have a simple classifier and you have correctly classified a "large" training set
		- "Simple" as measured through a complexity measure such as VC dimension or Rademacher complexity
	- Chances are you'll correctly classify new points also (you've already seen a large chunk of the distribution)
- Traditional generalization error arguments don't work for NNs
	- In some ways, it is surprising that they generalize at all
		- There are many methods to fit the training data that don't generalize

Random Labels

- First experiment in the paper
- Randomly shuffle all labels
	- By design, generalization isn't possible
- One way of assessing the NN capacity
	- Is it able to learn (i.e., memorize) even the shuffled labels?
	- Is the learning going to slow down or be otherwise adversely affected by the irregular training set?

Random Pixels and Shuffled Pixels

- Second set of experiments
- Random pixels: keep the original labels, but replace all pixels with random noise
	- –Once again, generalization isn't possible
- Shuffled pixels: keep the original labels, but shuffle pixels using the same transformation for all images
	- Depending on the transformation, this may add little to significant noise

Training Results, CIFAR10

- In all cases, the NN is able to memorize the entire training set!
- Training with random labels takes the longest but it still converges to 0 loss
	- Training with random pixels is faster probably because the data is more separated in space due to the noise

Label corruption, CIFAR10

- In order to assess the effect of label corruption on training and generalization, the authors also try corrupting a fraction of the labels
	- Ranging from 0% to 100% of all labels are corrupted
- Higher label corruption makes it significantly harder to overfit the training set
- Higher label corruption leads to higher generalization error

Training/Test Results Summary, CIFAR10

- All sufficiently large models can perfectly overfit training data
- Regularization improves generalization
	- But not necessary or sufficient
	- Major overfitting even with generalization
- Both convolution and fully-connected NNs show the same trends

Table 1. The training and test accuracy (in %) of various models on the CIFAR10 dataset.

- Similar to CIFAR10
	- –Overfitting only 95% of training data (still very surprising!)
- Regularization helps generalization
	- But once again not necessary or sufficient (still major overfitting even with regularization)

Table 2 shows the performance on Imagenet with true labels and random labels, respectively.

- Remember Occam's Razor
	- Usually want the simplest model that can learn the task
	- This is what regularization tries to achieve
- Standard deep learning regularization techniques (dropout, weight decay, batch normalization) do not prevent overfitting in CIFAR10
	- –Only works for some smaller models (AlexNet) on ImageNet

NN Expressivity

- Turns out that it doesn't take a very large NN to perfectly overfit a given training set
- **Theorem**: Given a training set $S = \{(x_1y_1), ..., (x_n, y_n)\}$ of size n , where each $x_i \in \mathbb{R}^d$, there exists a 2-layer NN with ReLU activations and $2n + d$ weights that can perfectly overfit S.
- Proof is not very hard
- This means that even very high-dimensional datasets can be overfit with small NNs
	- Hence we need to rethink generalization

Conclusion

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- Generalization is one of the most important aspects of ML
- It is especially important for expressive models such as neural networks where overfitting is very easy
- The most robust method of establishing your model's generalization performance is through a test set
	- The larger and more diverse, the better!